



# **PRODUCT DATA SHEET**



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Datasheet Re

Sample

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO\_questions@jgsemi.com.



#### **General Description**

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
-30V	9.5m $Ω$	-25A

#### **Features**

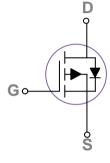
- -30V, -25A,  $RDS(ON) = 9.5m\Omega@VGS = -10V$
- Fast switching
- Green Device Available
- Suit for -4.5V Gate Drive Applications

### **Applications**

- MB / VGA / Vcore
- POL Applications
- Load Switch
- LED Application







#### Absolute Maximum Ratings Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	-30	V
$V_{GS}$	Gate-Source Voltage	±20	V
1	Drain Current – Continuous (T <sub>C</sub> =25°C)	-25	Α
ID	Drain Current – Continuous (T <sub>C</sub> =100°C)	-18	Α
I <sub>DM</sub>	Drain Current – Pulsed <sup>1</sup>	-75	Α
D	Power Dissipation (T <sub>C</sub> =25°C)	35	W
$P_D$	Power Dissipation – Derate above 25°C	0.18	W/°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
T <sub>J</sub>	Operating Junction Temperature Range	-55 to 125	°C

#### Thermal Characteristics

Symbol Parameter		Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		35	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case		5.4	°C/W



# Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise

#### noted) Off Characteristics

Symbol	Parameter	Conditions		Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA				V
$\triangle BV_{DSS}/\triangle T_{J}$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =-1mA		-0.03		V/°C
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =-30V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			-1	uA
	Dialii-Source Leakage Current	V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =125°C			-10	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}=\pm 20V$ , $V_{DS}=0V$			±100	nA

#### On Characteristics

D	Static Drain-Source On-Resistance	V <sub>GS</sub> =-10V , I <sub>D</sub> =-12A		9.5	13	mΩ
INDS(ON)	R <sub>DS(ON)</sub> Static Drain-Source On-Resistance	$V_{GS}$ =-4.5 $V$ , $I_D$ =-7 $A$		13	18	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V V 1 050 A		-1.5	-2.5	V
$\triangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	$V_{GS}=V_{DS}$ , $I_D=-250uA$		4		mV/°C
gfs	Forward Transconductance	V <sub>DS</sub> =-10V , I <sub>D</sub> =-8A		10.5		S

#### Dynamic and switching Characteristics

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$Q_g$	Total Gate Charge <sup>2, 3</sup>		 14.6	
$Q_gs$	Gate-Source Charge <sup>2, 3</sup>	$V_{DS}$ =-15V , $V_{GS}$ =-4.5V , $I_{D}$ =-8A	 4.1	 nC
$Q_gd$	Gate-Drain Charge <sup>2,3</sup>		 6.3	
$T_{d(on)}$	Turn-On Delay Time <sup>2,3</sup>		 9	
$T_r$	Rise Time <sup>2, 3</sup>	$V_{DD}$ =-15V , $V_{GS}$ =-10V , $R_G$ =6 $\Omega$	 21.8	 no
$T_{d(off)}$	Turn-Off Delay Time <sup>2, 3</sup>	I <sub>D</sub> =-1A	 59.8	 ns
$T_f$	Fall Time <sup>2,3</sup>		 14.4	
C <sub>iss</sub>	Input Capacitance		 1730	
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , F=1MHz	 230	 pF
C <sub>rss</sub>	Reverse Transfer Capacitance		 200	

# Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-25	Α
I <sub>SM</sub>	Pulsed Source Current	VG-VD-UV , FOICE Cullent			-50	Α
$V_{SD}$	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C			-1.2	V

#### Note

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 3. Essentially independent of operating temperature.

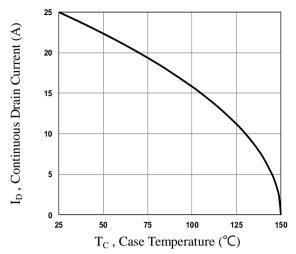


Fig.1 Continuous Drain Current vs. T<sub>c</sub>

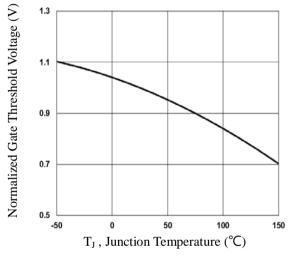


Fig.3 Normalized  $V_{th}$  vs.  $T_J$ 

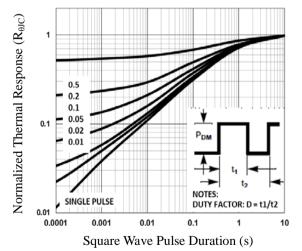


Fig.5 Normalized Transient Impedance

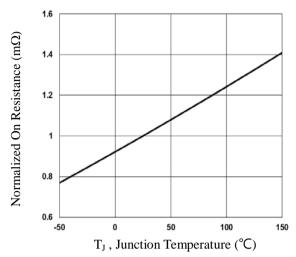


Fig. 2 Normalized RDSON vs. T<sub>J</sub>

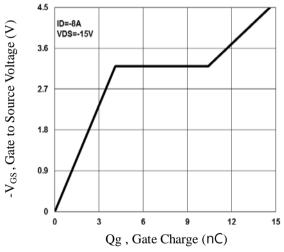


Fig.4 Gate Charge Waveform

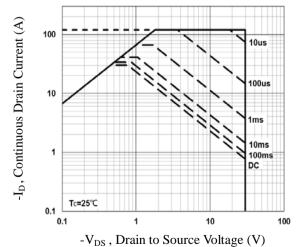
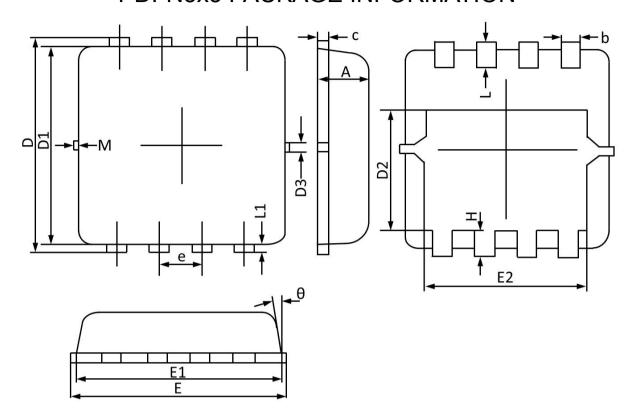


Fig.6 Maximum Safe Operation Area



# PDFN3x3 PACKAGE INFORMATION



Symbol	Dimensions I	n Millimeters	Dimension	s In Inches	
Symbol	Min	Max	Min	Max	
A	0.700	0.800	0.028	0.031	
b	0.250	0.350	0.010	0.013	
С	0.100	0.250	0.004	0.009	
D	3.250	3.450	0.128	0.135	
D1	3.000	3.200	0.119	0.125	
D2	1.780	1.980	0.070	0.077	
D3	0.130	0.130 REF		REF	
E	3.200	3.400	0.126	0.133	
<b>E</b> 1	3.000	3.200	0.119	0.125	
E2	2.390	2.590	0.094	0.102	
e	0.650 BSC		0.026	BSC	
Н	0.300	0.500	0.011	0.019	
L	0.300	0.500	0.011	0.019	
L1	0.130	REF	0.005 REF		
$\theta$	<b>0</b> °	12°	<b>0</b> °	12°	
M	0.150	REF	0.006 REF		



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